

**Search Notes**

Application/Control No.

10/655,816

Examiner

Phi D. A

Applicant(s)/Patent under  
Reexamination

PRINCE ET AL.

Art Unit

3637

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see attached		